


<b>Search Notes</b>  	<b>Application/Control No.</b>  10559365	<b>Applicant(s)/Patent Under Reexamination</b>  YANG, CHEK LON
	<b>Examiner</b>  RENEE DANEGA	<b>Art Unit</b>  3736

SEARCHED			
Class	Subclass	Date	Examiner
600	573	6/18/08	RAD
604	86, 244	6/18/08	RAD

SEARCH NOTES		
Search Notes	Date	Examiner
PALM Inventor Search	6/18/08	RAD
EAST Search	6/18/08	RAD
PLUS Search	6/18/08	RAD

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner